

Application/Control No.	Applicant(s)/Patent under Reexamination
09/586,601	ONO, SHUJI
Examiner	Art Unit
Nhan T. Tran	2622

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search all classes - see search history printout	9/21/2007	NT		